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PATENT
Docket No. 514802002600

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In The Application Of:
Mitsuyuki ASAKI and Akira KINTAKA

Serial No.: Not Yet Assigned

Filing Date: Concurrently Herewith

For: PATTERN WIDTH MEASURING
APPARATUS, PATTERN WIDTH
MEASURING METHOD, AND
ELECTRON BEAM EXPOSURE
APPARATUS

Examiner: Not yet assigned

Group Art Unit: Not yet assigned

**INFORMATION DISCLOSURE
STATEMENT UNDER 37 C.F.R. § 1.97**

Mail Stop Patent Application
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Dear Sir:

Pursuant to 37 C.F.R. § 1.97 and § 1.98, Applicants submit for consideration in the above-identified application the documents listed on the attached Form PTO-1449. Copies of the documents are also submitted herewith. The Examiner is requested to make these documents of record.

This Information Disclosure Statement is submitted with the application; accordingly, no fee or separate requirements are required.

Applicant would appreciate the Examiner initialing and returning the Form PTO-1449, indicating that the information has been considered and made of record herein.

The information contained in this Information Disclosure Statement under 37 C.F.R. § 1.97 is to the best of my knowledge and is not to be construed as a representation that: (i) a complete search has been made; (ii) additional information material to the examination of this application does not exist; (iii) the information, protocols, results and the like reported by third parties are accurate or enabling; or (iv) the above information constitutes prior art to the subject invention.

In the unlikely event that the transmittal letter is separated from this document and the Patent Office determines that an extension and/or other relief is required, applicant petitions for any required relief including extensions of time and authorizes the Assistant Commissioner to charge the cost of such petitions and/or other fees due in connection with the filing of this document to **Deposit Account No. 03-1952** referencing 514802002600. However, the Assistant Commissioner is not authorized to charge the cost of the issue fee to the Deposit Account.

Dated: September 18, 2003

Respectfully submitted,

By: 

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| Form PTO-1449 INFORMATION DISCLOSURE CITATION IN AN APPLICATION <i>(Use several sheets if necessary)</i> | | | | Docket Number 514802002600 | | Application Number Currently Unknown | |
| | | | | Applicant Mitsuyuki ASAKI and Akira KINTAKA | | | |
| | | | | Filing Date Concurrently herewith | | Group Art Unit | |
| | | | | Mailing Date: September 18, 2003 | | | |
| U.S. PATENT DOCUMENTS | | | | | | | |
| Examiner Initials | Ref. No. | Date | Document No. | Name | Class | Subclass | Filing Date If Appropriate |
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| FOREIGN PATENT DOCUMENTS | | | | | | | |
| Examiner Initials | Ref. No. | Date | Document No. | Country | Class | Subclass | Translation YES NO |
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| OTHER DOCUMENTS <i>(including author, title, Date, Pertinent Pages, Etc.)</i> | | | | | | | |
| Examiner Initials | Ref. No. | Title | | | | | |
| | 1. | Y. Furuya, et al., "Model S-6000 Field Emission CD Measurement SEM" abstract of the 93rd Workshop of the 132nd Committee (Electron and Ion Beam Science and Technology) of Japan Society for the Promotion of Science, November 8, 1985, pp. 1-5 | | | | | |
| | 2. | M. Miyoshi, et al., "Topographic Contrast in Scanning Electron Microscope During CD Measurement" abstract of the 93rd Workshop of the 132nd Committee (Electron and Ion Beam Science and Technology) of Japan Society for the Promotion of Science, November 8, 1985, pp. 109-114 | | | | | |
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| EXAMINER: (examiner) | | | | DATE CONSIDERED: | | | |
| EXAMINER: Initial if citation considered, whether or not the citation conforms with MPEP 609. Draw a line through the citation if not in conformance and not considered. Include a copy of this form with next communication to applicant. | | | | | | | |